

Notic of R ferences Cit d	Application/Control No. 09/936,040	Applicant(s)/Patent Under Reexamination YUDASAKA ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,578,865 /	11-1996	Vu et al	257/611
	B	US-6,337,500 /	01-2002	Nakaoka et al	257/349
	C	US-6,034,408 /	03-2000	Ghoshal	257/467
	D	US-6,064,091 /	05-2000	Deane et al	257/347
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10-79513 /	03-1998	Japan	Suzuki et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.